Mechanical Shock

Solderability

Vibration

**Resistance to Soldering Heat** 

**Resistance to Solvents** 

**Temperature Cycling** 



EH35 25

Series -RoHS Compliant (Pb-free) 5.0V 4 Pad 3.2mm x 5mm Ceramic SMD HCMOS/TTL High Frequency Oscillator

Frequency Tolerance/Stability ±25ppm Maximum

Operating Temperature Range 0°C to +70°C

Nominal Frequency

24.576MHz

-24.576M

Pin 1 Connection

Tri-State (Disabled Output: High Impedance)

Duty Cycle 50 ±10(%)

TS

| 24.576MHz  |
|--|
| ±25ppm Maximum (Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, 1st Year Aging at 25°C, Shock, and Vibration) |
| ±5ppm/year Maximum   |
| 0°C to +70°C   |
| 5.0Vdc ±10%  |
| 50mA Maximum (No Load)   |
| 2.4Vdc Minimum with TTL Load, Vdd-0.4Vdc Minimum with HCMOS Load (IOH = -16mA)   |
| 0.4Vdc Maximum with TTL Load, 0.5Vdc Maximum with HCMOS Load (IOL = +16mA)   |
| 6nSec Maximum (Measured at 0.8Vdc to 2.0Vdc with TTL Load or at 20% to 80% of waveform with HCMOS Load)  |
| 50 ±10(%) (Measured at 1.4Vdc with TTL Load or at 50% of waveform with HCMOS Load)   |
| 10TTL Load or 50pF HCMOS Load Maximum  |
| CMOS   |
| Tri-State (Disabled Output: High Impedance)  |
| +2.2Vdc Minimum to enable output, +0.8Vdc Maximum to disable output (High Impedance), No Connect t enable output.  |
| ±250pSec Maximum, ±100pSec Typical   |
| ±50pSec Maximum, ±30pSec Typical   |
| 10mSec Maximum   |
| -55°C to +125°C  |
| HANICAL SPECIFICATIONS   |
| MIL-STD-883, Method 1014, Condition A  |
|  |
|  |

MIL-STD-202, Method 213, Condition C

MIL-STD-883, Method 2007, Condition A

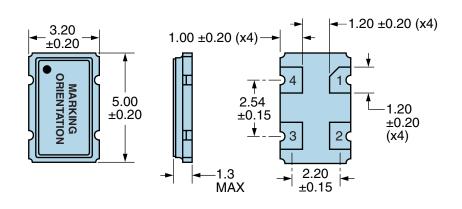
MIL-STD-202, Method 210

MIL-STD-202, Method 215

MIL-STD-883, Method 2003

MIL-STD-883, MEthod 1010

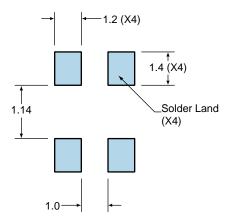
### **MECHANICAL DIMENSIONS (all dimensions in millimeters)**



| PIN  | CONNECTION         |
|------|--------------------|
| 1    | Tri-State          |
| 2    | Ground/Case Ground |
| 3    | Output             |
| 4    | Supply Voltage     |
| LINE | MARKING            |
|      |                    |

#### Suggested Solder Pad Layout

All Dimensions in Millimeters

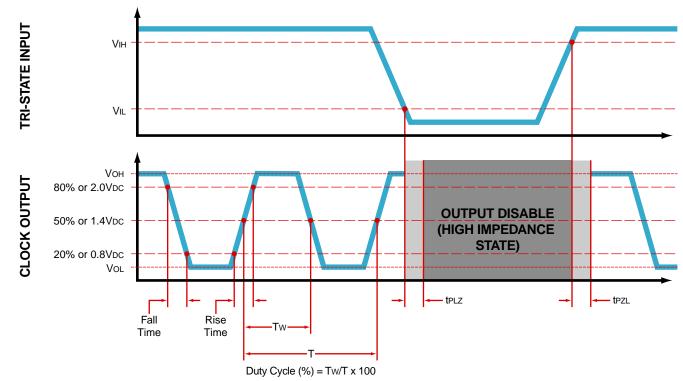


All Tolerances are ±0.1



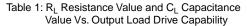


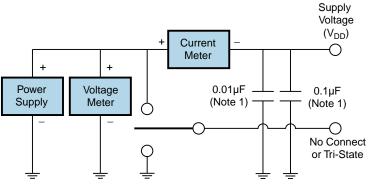
#### **OUTPUT WAVEFORM & TIMING DIAGRAM**

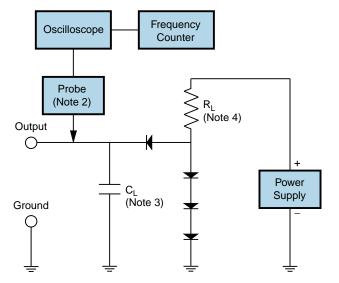


#### Test Circuit for TTL Output

| Output Load<br>Drive Capability | R <sub>L</sub> Value<br>(Ohms) | C <sub>L</sub> Value<br>(pF) |
|---------------------------------|--------------------------------|------------------------------|
| 10TTL                           | 390                            | 15                           |
| 5TTL                            | 780                            | 15                           |
| 2TTL                            | 1100                           | 6                            |
| 10LSTTL                         | 2000                           | 15                           |
| 1TTL                            | 2200                           | 3                            |







Note 1: An external 0.1µF low frequency tantalum bypass capacitor in parallel with a 0.01µF high frequency ceramic bypass capacitor close to the package ground and V<sub>DD</sub> pin is required.

Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth

(>300MHz) passive probe is recommended.

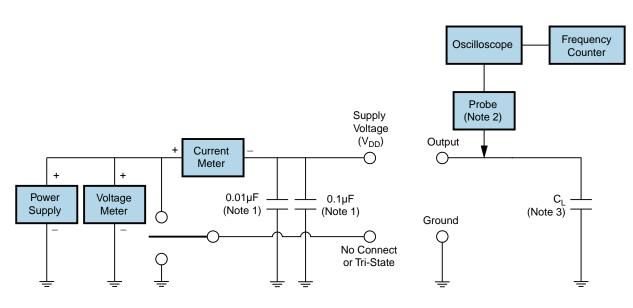
Note 3: Capacitance value  $C_L$  includes sum of all probe and fixture capacitance.

Note 4: Resistance value R<sub>L</sub> is shown in Table 1. See applicable specification sheet for 'Load Drive Capability'.

Note 5: All diodes are MMBD7000, MMBD914, or equivalent.



### **Test Circuit for CMOS Output**



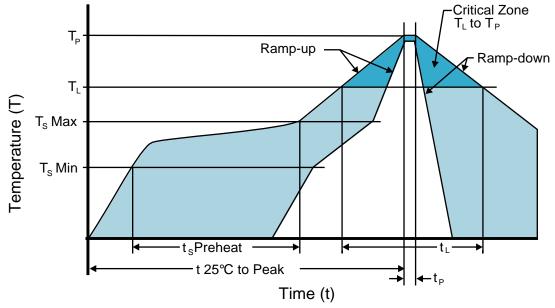
Note 1: An external 0.1µF low frequency tantalum bypass capacitor in parallel with a 0.01µF high frequency ceramic bypass capacitor close to the package ground and V<sub>DD</sub> pin is required.

Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

Note 3: Capacitance value  $\dot{C}_1$  includes sum of all probe and fixture capacitance.

## **ECLIPTEK** CORPORATION

## **Recommended Solder Reflow Methods**



### **High Temperature Infrared/Convection**

EH3525TS-24.576M

| T <sub>s</sub> MAX to T <sub>L</sub> (Ramp-up Rate)         | 3°C/second Maximum                   |
|---|--------------------------------------|
| Preheat   |                                      |
| - Temperature Minimum (T <sub>s</sub> MIN)                  | 150°C                                |
| <ul> <li>Temperature Typical (T<sub>s</sub> TYP)</li> </ul> | 175°C                                |
| <ul> <li>Temperature Maximum (T<sub>s</sub> MAX)</li> </ul> | 200°C                                |
| - Time (t <sub>s</sub> MIN)                                 | 60 - 180 Seconds                     |
| Ramp-up Rate (T⊾ to T <sub>P</sub> )                        | 3°C/second Maximum                   |
| Time Maintained Above:                                      |                                      |
| - Temperature (T∟)  | 217°C                                |
| - Time (t∟)   | 60 - 150 Seconds                     |
| Peak Temperature (T <sub>P</sub> )                          | 260°C Maximum for 10 Seconds Maximum |
| Target Peak Temperature (T <sub>P</sub> Target)             | 250°C +0/-5°C                        |
| Time within 5°C of actual peak (t <sub>P</sub> )            | 20 - 40 seconds                      |
| Ramp-down Rate  | 6°C/second Maximum                   |
| Time 25°C to Peak Temperature (t)                           | 8 minutes Maximum                    |
| Moisture Sensitivity Level                                  | Level 1                              |
|   |                                      |

## **ECLIPTEK** CORPORATION

## **Recommended Solder Reflow Methods**

EH3525TS-24.576M



### Low Temperature Infrared/Convection 240°C

| T <sub>s</sub> MAX to T <sub>L</sub> (Ramp-up Rate) | 5°C/second Maximum                                     |
|---|--|
| Preheat   |  |
| - Temperature Minimum (T <sub>s</sub> MIN)          | N/A  |
| - Temperature Typical (T <sub>s</sub> TYP)          | 150°C  |
| - Temperature Maximum (T <sub>s</sub> MAX)          | N/A  |
| - Time (t <sub>s</sub> MIN)                         | 60 - 120 Seconds                                       |
| Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )    | 5°C/second Maximum                                     |
| Time Maintained Above:                              |  |
| - Temperature (T <sub>L</sub> )                     | 150°C  |
| - Time (t∟)   | 200 Seconds Maximum                                    |
| Peak Temperature (T <sub>P</sub> )                  | 240°C Maximum  |
| Target Peak Temperature (T <sub>P</sub> Target)     | 240°C Maximum 1 Time / 230°C Maximum 2 Times           |
| Time within 5°C of actual peak (t <sub>p</sub> )    | 10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time |
| Ramp-down Rate                                      | 5°C/second Maximum                                     |
| Time 25°C to Peak Temperature (t)                   | N/A  |
| Moisture Sensitivity Level                          | Level 1  |

#### Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum.

#### **High Temperature Manual Soldering**

260°C Maximum for 5 seconds Maximum, 2 times Maximum.